



# **MOSFET** – Power, N-Channel

# 60 V, 50 A, 22 m $\Omega$

## RFP50N06

These N-Channel power MOSFETs are manufactured using the MegaFET process. This process, which uses feature sizes approaching those of LSI integrated circuits gives optimum utilization of silicon, resulting in outstanding performance. They were designed for use in applications such as switching regulators, switching converters, motor drivers, and relay drivers. These transistors can be operated directly from integrated circuits.

Formerly developed type TA49018.

#### **Features**

- 50 A, 60 V
- $r_{DS(ON)} = 0.022 \Omega$
- Temperature Compensating PSPICE™ Model
- Peak Current vs. Pulse Width Curve
- UIS Rating Curve
- 175°C Operating Temperature
- This Device is Pb-Free and is RoHS Compliant

#### **Specifications**

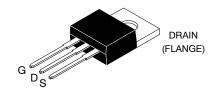
#### **ABSOLUTE MAXIMUM RATINGS**

(T<sub>C</sub> = 25°C, unless otherwise specifieded)

Symbol	Para	Rating	Unit	
V <sub>DSS</sub>	Drain to Source Volt	60	V	
$V_{DGR}$	Drain to Gate Voltag (Note 1)	60	V	
$V_{GS}$	Gate to Source Volta	to Source Voltage		
I <sub>D</sub>	Drain Current	Continuous (Figure 2)	50	Α
I <sub>DM</sub>		Pulsed	(Figure 5)	
E <sub>AS</sub>	Pulsed Avalanche F	(Figure 6)		
$P_{D}$	Power Dissipation	131	W	
	Linear Derating F	0.877	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Stora	-55 to 175	°C	
TL	Maximum Temperat Leads at 0.063 inch for 10 s	300	°C	
T <sub>pkg</sub>	Maximum Temperature for Soldering Package Body for 10 s, see Techbrief 334			°C

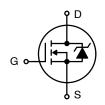
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1.  $T_J = 25^{\circ}C$  to  $150^{\circ}C$ 



TO-220-3LD CASE 340AT

#### SYMBOL



#### **MARKING DIAGRAM**



\$Y = onsemi Logo = Assembly Plant Code &Z

= Date Code (Year & Week) &K

&3

RFP50N06 = Specific Device Code

#### **ORDERING INFORMATION**

Device	Package	Shipping
RFP50N06	TO-220-3LD (Pb-Free)	800 units / Tube

1

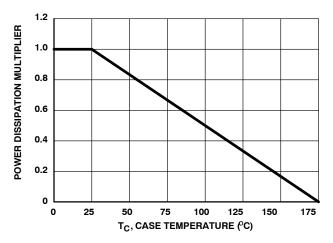
# **ELECTRICAL CHARACTERISTICS** ( $T_C = 25^{\circ}C$ , unless otherwise noted)

Parameter	Symbol	Test	Conditions	Min	Тур	Max	Units
Drain to Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V (Figure 11)		60	-	_	V
Gate to Source Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 250 \mu A$ (Figure 10)		2	-	4	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, \ V_{GS} = 0 \text{ V}$ $V_{CS} = 150^{\circ}\text{C}$	T <sub>C</sub> = 25°C	-	-	1	μΑ
			-	-	50	μΑ	
Gate to Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20 V	V <sub>GS</sub> = ±20 V		-	±100	nA
Drain to Source On Resistance	r <sub>DS(ON)</sub>	I <sub>D</sub> = 50 A, V <sub>GS</sub> = 10 V (Figure 9)		-	-	0.022	Ω
Turn-On Time	t <sub>ON</sub>	$V_{DD}$ = 30 V, $I_{D}$ = 50 A $R_{L}$ = 0.6 $\Omega$ , $V_{GS}$ = 10 V $R_{GS}$ = 3.6 $\Omega$ (Figure 13)		-	-	95	ns
Turn-On Delay Time	t <sub>d(ON)</sub>			-	12	_	ns
Rise Time	t <sub>r</sub>			-	55	_	ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>			-	37	_	ns
Fall Time	t <sub>f</sub>			-	13	_	ns
Turn-Off Time	t <sub>OFF</sub>			-	-	75	ns
Total Gate Charge	Q <sub>g(TOT)</sub>	V <sub>GS</sub> = 0 to 20 V	V <sub>DD</sub> = 48 V, I <sub>D</sub> = 50 A,	-	125	150	nC
Gate Charge at 10V	Q <sub>g(10)</sub>	$V_{GS} = 0$ to 10 V	$R_L = 0.96 \Omega$ $I_{g(REF)} = 1.45 \text{ mA}$	-	67	80	nC
Threshold Gate Charge	Q <sub>g(TH)</sub>	$V_{GS} = 0$ to 2 V	(Figure 13)	-	3.7	4.5	nC
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> =	= 0 V	-	2020	_	pF
Output Capacitance	C <sub>OSS</sub>	f = 1 MHz (Figure 12)		-	600	_	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			-	200	_	pF
Thermal Resistance Junction to Case	$R_{ heta JC}$	(Figure 3)		-	-	1.14	°C/W
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	TO-220		-	-	62	°C/W
SOURCE TO DRAIN DIODE CHARACTERISTICS							
Source to Drain Diode Voltage	$V_{SD}$	I <sub>SD</sub> = 50 A		-	-	1.5	V
		1					1

Source to Drain Diode Voltage	$V_{SD}$	I <sub>SD</sub> = 50 A	ı	_	1.5	V
Output Capacitance	t <sub>rr</sub>	$I_{SD}$ = 50 A, $dI_{SD}/dt$ = 100 A/ $\mu$ s	-	_	125	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### TYPICAL PERFORMANCE CHARACTERISTICS (unless otherwise specified)



60 50 ID, DRAIN CURRENT (A) 40 30 20 10 0 25 50 75 100 125 150 175 T<sub>C</sub>, CASE TEMPERATURE (°C)

Figure 1. Normalized Power Dissipation vs. Case Temperature

Figure 2. Maximum Continuous Drain Current vs. Case Temperature

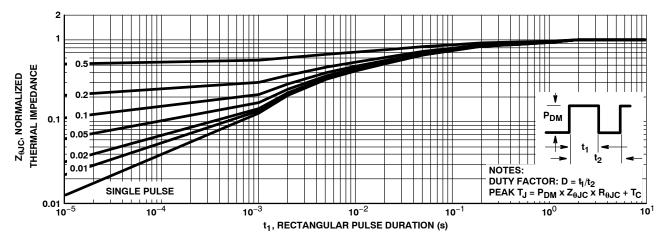


Figure 3. Normalized Maximum Transient Thermal Impedance

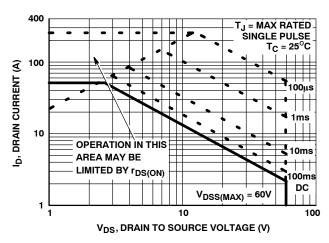


Figure 4. Forward Bias Safe Operating Area

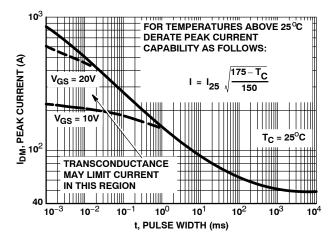


Figure 5. Peak Current Capability



#### TYPICAL PERFORMANCE CHARACTERISTICS (unless otherwise specified) (continued)

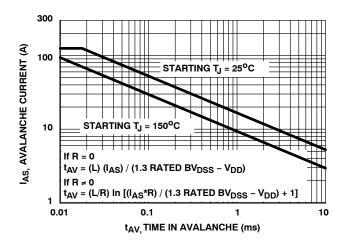


Figure 6. Unclamped Inductive Switching Capability

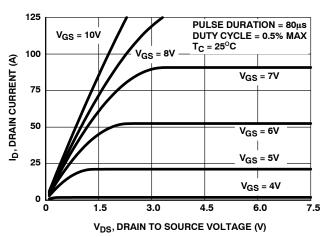


Figure 7. Saturation Characteristics

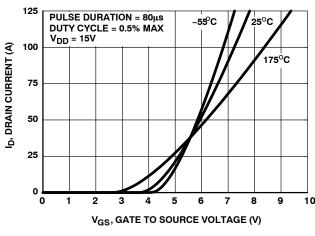


Figure 8. Transfer Characteristics

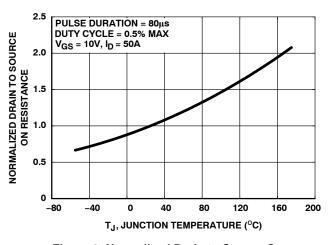


Figure 9. Normalized Drain to Source On Resistance vs. Junction Temperature

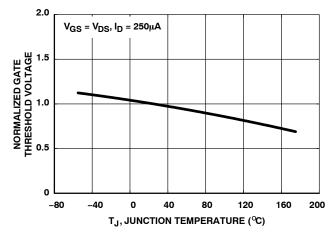


Figure 10. Normalized Gate Threshold Voltage vs. Junction Temperature

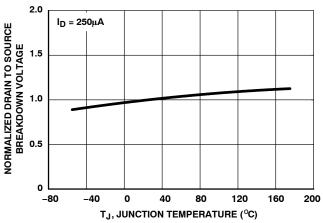


Figure 11. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

### TYPICAL PERFORMANCE CHARACTERISTICS (unless otherwise specified) (continued)

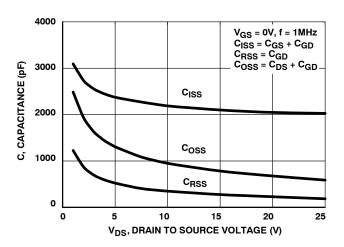


Figure 12. Capacitance vs. Drain to Source Voltage

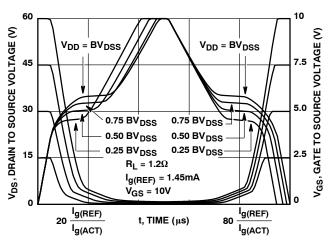


Figure 13. Normalized Switching Waveforms for Constant Gate Current

### **TEST CIRCUITS AND WAVEFORMS**

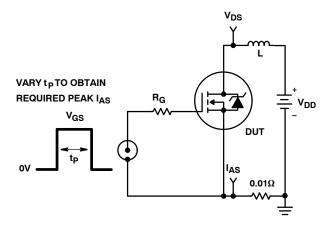


Figure 14. Unclamped Energy Test Circuit

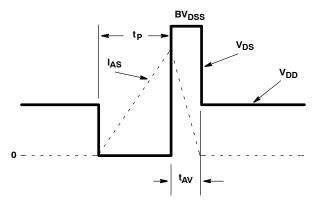


Figure 15. Unclamped Energy Waveforms

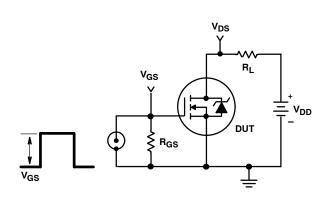


Figure 16. Switching Time Test Circuit

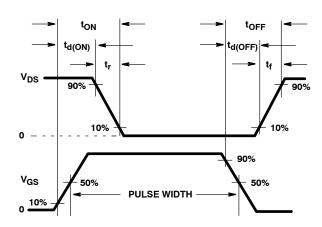


Figure 17. Switching Waveforms

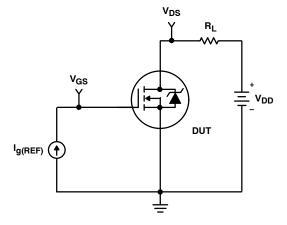


Figure 18. Gate Charge Test Circuit

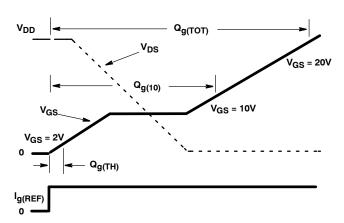


Figure 19. Gate Charge Waveforms



#### **PSPICE ELECTRICAL MODEL**

.SUBCKT RFP50N06213

REV 2/22/93

\*NOM TEMP = 25°C

CA 12 8 3.68e-9 CB 15 14 3.625e-9 CIN 6 8 1.98e-9

DBODY 7 5 DBDMOD DBREAK 5 11DBKMOD DPLCAP 10 5 DPLCAPMOD

EBREAK 11 7 17 18 64.59 EDS 14 8 5 8 1 EGS 13 8 6 8 1 ESG 6 10 6 8 1 EVTO 20 6 18 8 1

IT 8 17 1

LDRAIN 2 5 1e-9 LGATE 1 9 5.65e-9 LSOURCE 3 7 4.13e-9

MOS1 16 6 8 8 MOSMOD M=0.99 MOS2 16 21 8 8 MOSMOD M=0.01

RBREAK 17 18 RBKMOD 1 RDRAIN 5 16 RDSMOD 1e-4 RGATE 9 20 0.690 RIN 6 8 1e9 RSOURCE 8 7 RDSMOD 12e-3 RVTO 18 19 RVTOMOD 1

S1A 6 12 13 8 S1AMOD S1B 13 12 13 8 S1BMOD S2A 6 15 14 13 S2AMOD S2B 13 15 14 13 S2BMOD

VBAT 8 19 DC 1 VTO 21 6 0.678

DRAIN 5 **-**0 2 10 LDRAIN **DPLCAP RDRAIN** DBREAK Y **ESG** VTO DBODY MOS<sub>2</sub> **EVTO** GATE 21 20 18 11 MOS1 8 LGATE RGATE **EBREAK** 18 RIN ≥ CIN RSOURCE **LSOURCE** 8 7 **-**o 3 SOURCE S1A o ပ S2A **RBREAK** 15 13 14 17 18 13 8 S1B P Q SZB **RVTO** 13 CA CB  $(\dagger)$ IT 19 <u>6</u> 8 **5 VBAT** EGS ( **EDS** 

.MODEL DBDMOD D (IS=9.85e-13 RS=4.91e-3 TRS1=2.07e-3 TRS2=2.51e-7 CJO=2.05e-9 TT=4.33e-8)

.MODEL DBKMOD D (RS=1.98e-1 TRS1=2.35E-4 TRS2=-3.83e-6)

.MODEL DPLCAPMOD D (CJO=1.42e-9 IS=1e-30 N=10)

.MODEL MOSMOD NMOS (VTO=3.65 KP=35 IS=1e-30 N=10 TOX=1 L=1u W=1u)

.MODEL RBKMOD RES (TC1=1.23e-3 TC2=-2.34e-7)

.MODEL RDSMOD RES (TC1=5.01e-3 TC2=1.49e-5)

.MODEL RVTOMOD RES (TC1=-5.03e-3 TC2=-5.16e-6)

.MODEL S1AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-6.75 VOFF=-2.5)

.MODEL S1BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-2.5 VOFF=-6.75)

.MODEL S2AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-2.7 VOFF=2.3)

.MODEL S2BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=2.3 VOFF=-2.7)

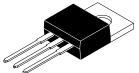
.ENDS

NOTE: For further discussion of the PSPICE model consult A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options; authors, William J. Hepp and C. Frank Wheatley.

PSPICE is a trademark of MicroSim Corporation.

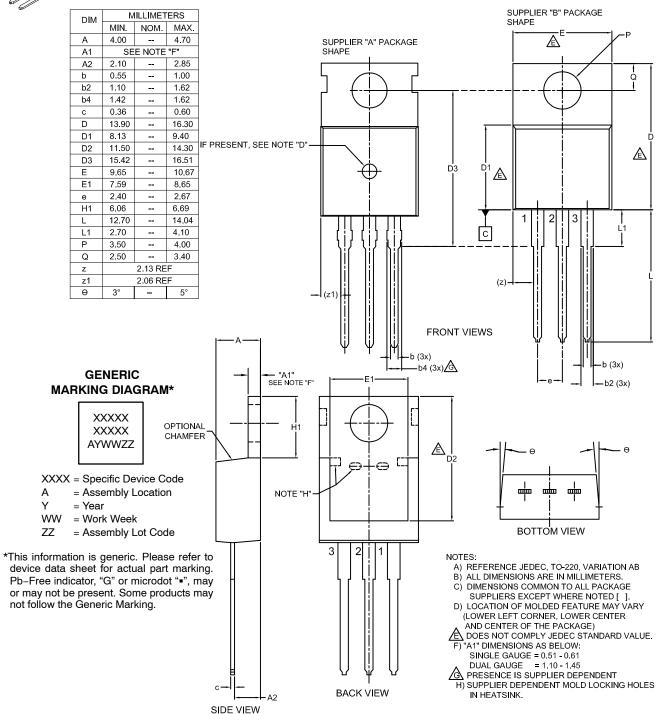






#### TO-220-3LD CASE 340AT ISSUE B

#### **DATE 08 AUG 2022**



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